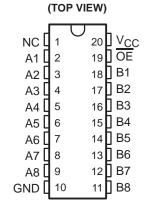
- Functionally Equivalent to QS3245
- Standard '245-Type Pinout
- 5-Ω Switch Connection Between Two Ports
- TTL-Compatible Control Input Levels
- Package Options Include Shrink Small-Outline (DB), Plastic Small-Outline (DW), and Thin Shrink Small-Outline (PW) Packages

description

The SN74CBT3245 provides eight bits of high-speed TTL-compatible bus switching in a standard '245 device pinout. The low on-state resistance of the switch allows connections to be made with minimal propagation delay.



DB, DW, OR PW PACKAGE

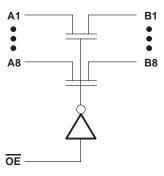
The device is organized as one 8-bit switch. When output enable (\overline{OE}) is low, the switch is on and port A is connected to port B. When \overline{OE} is high, the switch is open and a high-impedance state exists between the two ports.

The SN74CBT3245 is characterized for operation from −40°C to 85°C.

FUNCTION TABLE

INPUT	INPUTS/ OUTPUTS			
OE	A,B			
L	A = B			
Н	Z			

logic diagram





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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, V _{CC}	−0.5 V to 7	V
Input voltage range, V _I (see Note 1)	−0.5 V to 7	٧
Continuous channel current	128 m	١A
Input clamp current, I_{IK} ($V_{I/O} < 0$)	–50 m	١A
Maximum power dissipation at T _A = 55°C (in still air) (see Note 2): DB package 0.6	W
	DW package 1.6	W
	PW package 0.7	W
Storage temperature range, T _{sto}	65°C to 150°	,C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

recommended operating conditions

		MIN	MAX	UNIT
VCC	Supply voltage	4	5.5	V
VIH	High-level control input voltage	2		V
V _{IL}	Low-level control input voltage		0.8	V
TA	Operating free-air temperature	-40	85	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PA	RAMETER	TEST CONDITIONS		MIN	TYP‡	MAX	UNIT	
VIK		V _{CC} = 4.5 V,	$I_{I} = -18 \text{ mA}$				-1.2	V
lį		V _{CC} = 5.5 V,	$V_I = 5.5 \text{ V or GND}$				±5	μΑ
ICC		V _{CC} = 5.5 V,	$I_{O} = 0$,	$V_I = V_{CC}$ or GND			50	μΑ
∆I _{CC} §	Control pins	V _{CC} = 5.5 V,	One input at 3.4 V,	Other inputs at V _{CC} or GND			3.5	mA
Ci	Control pins	V _I = 3 V or 0				3		pF
C _{io(OFF}	·)	$V_{O} = 3 \text{ V or } 0,$	OE = V _{CC}			6		pF
r _{on} ¶		V _{CC} = 4 V,	$V_1 = 2.4 V$,	I _I = 15 mA				
			$V_{I} = 0,$	I _I = 64 mA		5	7	Ω
		V _{CC} = 4.5 V	$V_I = 0$,	I _I = 30 mA		5	7	22
			V _I = 2.4 V,	I _I = 15 mA		10	15	

[‡] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$.



^{2.} The maximum package power dissipation is calculated using a junction temperature of 150°C and a board trace length of 750 mils. For more information, refer to the *Package Thermal Considerations* application note in the 1994 *ABT Advanced BiCMOS Technology Data Book*, literature number SCBD002B.

[§] This is the increase in supply current for each input that is at the specified TTL voltage level rather than VCC or GND.

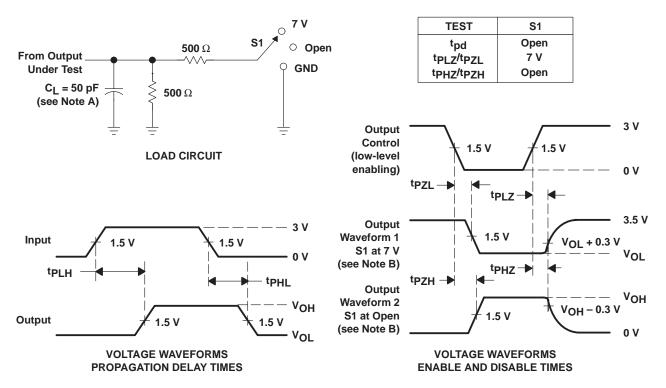
[¶] Measured by the voltage drop between the A and B terminals at the indicated current through the switch. On-state resistance is determined by the lower of the voltages of the two (A or B) terminals.

switching characteristics over recommended operating free-air temperature range, $C_L = 50 \text{ pF}$ (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	MIN	MAX	UNIT
t _{pd} †	A or B	B or A		0.25	ns
t _{en}	ŌĒ	A or B			ns
^t dis	ŌĒ	A or B			ns

[†] This parameter is characterized but not tested. This propagation delay is based on the RC time constant of the typical on-state resistance of the switch and a load capacitance of 50 pF.

PARAMETER MEASUREMENT INFORMATION



- NOTES: A. C_L includes probe and jig capacitance.
 - B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
 - C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, Z_O = 50 Ω , $t_f \leq$ 2.5 ns. $t_f \leq$ 2.5 ns.
 - D. The outputs are measured one at a time with one transition per measurement.
 - E. t_{PLZ} and t_{PHZ} are the same as t_{dis} .
 - F. tpzL and tpzH are the same as ten.
 - G. t_{PLH} and t_{PHL} are the same as t_{pd} .

Figure 1. Load Circuit and Voltage Waveforms

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